



<p>Searched</p> 	<p>Application/Control No.</p> <p>10707496</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>NGUYEN ET AL.</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
307	43	10/24/2006	HK
307	65	10/24/2006	HK
307	80	10/25/2006	HK
307	84	10/25/2006	HK
307	85	10/25/2006	HK
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	10707496	NGUYEN ET AL.
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Notes	Date	Examiner
307/43,64,65,80,84,85,87 (consulted Robert DeBeradinis)	04/25/2006	HK
361/20,21 (consulted Stephen W. Jackson)	04/25/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	10/25/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	11/13/2006	HK
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